SONY

Diagonal 6.0mm (Type 1/3) Progressive Scan CCD Image Sensor for B/W Cameras

ICX445ALA

Description

The ICX445ALA is a diagonal 6.0mm (Type 1/3) interline CCD solid-state image sensor with a square pixel array and 1.25M effective pixels.
Progressive scan enables all pixel signals to be output separately and sequentially within 1/22.5 second.
The sensitivity and smear are improved drastically through the adoption of EXview HAD CCD technology.

Features

- ◆ Supports following readout modes
  All-pixel scan mode (15 frame/s, 12.5 frame/s, 22.5 frame/s: Max.)
  Center cut-out mode (30 frame/s, 25 frame/s)
- ◆ Horizontal drive frequency: 36.0MHz, 29.0MHz
- ◆ High resolution, high sensitivity, low dark current, low smear
- ◆ Excellent anti-blooming characteristics
- ◆ No voltage adjustments (Reset gate and substrate bias need no adjustment.)
- ◆ 24-pin high precision plastic package (Dual-surface reference available)

Package

24-pin DIP (Plastic)

EXview HAD CCD™

* EXview HAD CCD is a trademark of Sony Corporation. The EXview HAD CCD is a CCD that drastically improves light efficiency by including near infrared light region as a basic structure of HAD (Hole-Accumulation Diode) sensor.

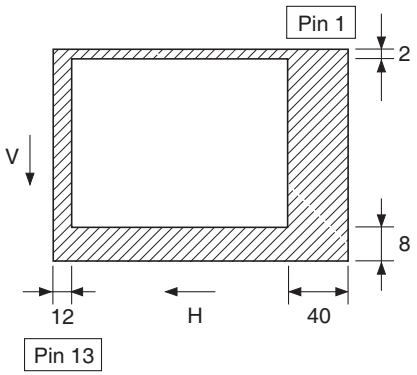
E06613C03

Device Structure

- ◆ Interline CCD image sensor
- ◆ Image size
  Diagonal 6.0mm (Type 1/3)
- ◆ Total number of pixels
  1348 (H) × 976 (V) approx. 1.32M pixels
- ◆ Number of effective pixels
  1296 (H) × 966 (V) approx. 1.25M pixels
- ◆ Number of active pixels
  1280 (H) × 960 (V) approx. 1.23M pixels
- ◆ Chip size
  6.26mm (H) × 5.01mm (V)
- ◆ Unit cell size
  3.75μm (H) × 3.75μm (V)
- ◆ Optical black
  Horizontal (H) direction: front 12 pixels, rear 40 pixels
  Vertical (V) direction: front 8 pixels, rear 2 pixels
- ◆ Number of dummy bits
  Horizontal (H) direction: front 4 pixels
  Vertical (V) direction: front 2 pixels
- ◆ Substrate material
  Silicon

Optical Black Position

(Top View)



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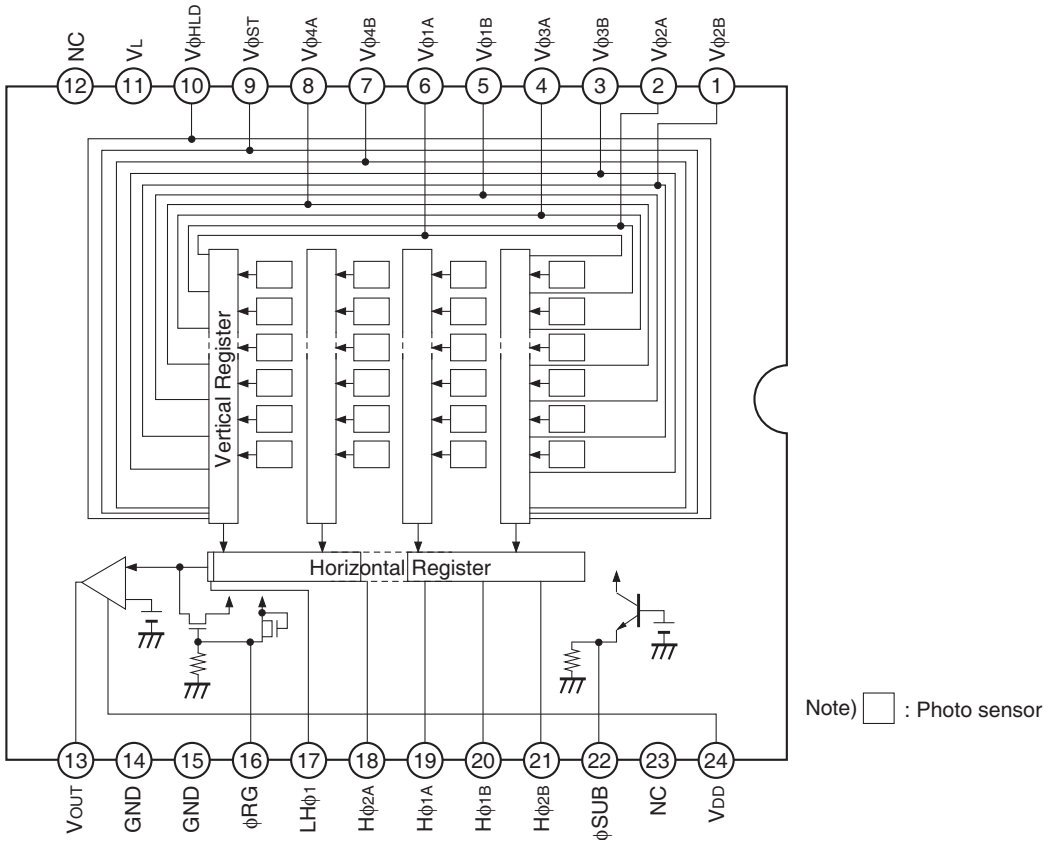
Block Diagram and Pin Configuration



Pin Description

Pin No.	Symbol	Description	Pin No.	Symbol	Description
1	Vφ2B	Vertical register transfer clock	13	VOUT	Signal output
2	Vφ2A	Vertical register transfer clock	14	GND	GND
3	Vφ3B	Vertical register transfer clock	15	GND	GND
4	Vφ3A	Vertical register transfer clock	16	φRG	Reset gate clock
5	Vφ1B	Vertical register transfer clock	17	LHφ1	Horizontal register final stage transfer clock
6	Vφ1A	Vertical register transfer clock	18	Hφ2A	Horizontal register transfer clock
7	Vφ4B	Vertical register transfer clock	19	Hφ1A	Horizontal register transfer clock
8	Vφ4A	Vertical register transfer clock	20	Hφ1B	Horizontal register transfer clock
9	VφST	Horizontal addition control clock	21	Hφ2B	Horizontal register transfer clock
10	VφHLD	Horizontal addition control clock	22	φSUB	Substrate clock
11	VL	Protective transistor bias	23	NC	
12	NC		24	VDD	Supply voltage

Absolute Maximum Ratings

Item		Ratings	Unit	Remarks
Against ϕSUB	V_{DD}, V_{OUT}, ϕRG – ϕSUB	–39 to +12	V	
	$V\phi_{2A}$, $V\phi_{2B}$, $V\phi_{3A}$, $V\phi_{3B}$ – ϕSUB	–46 to +17	V	
	$V\phi_{1A}$, $V\phi_{1B}$, $V\phi_{4A}$, $V\phi_{4B}$, $V\phi_{ST}$, $V\phi_{HLD}$, V_L – ϕSUB	–46 to +0.3	V	
	$H\phi_{1A}$, $H\phi_{1B}$, $H\phi_{2A}$, $H\phi_{2B}$, $LH\phi_1$, GND – ϕSUB	–39 to +0.3	V	
Against GND	V_{DD}, V_{OUT}, ϕRG – GND	–0.3 to +20	V	
	$V\phi_{1A}$, $V\phi_{1B}$, $V\phi_{2A}$, $V\phi_{2B}$, $V\phi_{3A}$, $V\phi_{3B}$, $V\phi_{4A}$, $V\phi_{4B}$, $V\phi_{ST}$, $V\phi_{HLD}$ – GND	–9.0 to +17	V	
	$H\phi_{1A}$, $H\phi_{1B}$, $H\phi_{2A}$, $H\phi_{2B}$, $LH\phi_1$ – GND	–9.0 to +4.2	V	
Against V_L	$V\phi_{2A}$, $V\phi_{2B}$, $V\phi_{3A}$, $V\phi_{3B}$ – V_L	–0.3 to +25	V	
	$V\phi_{1A}$, $V\phi_{1B}$, $V\phi_{4A}$, $V\phi_{4B}$, $V\phi_{ST}$, $V\phi_{HLD}$, $H\phi_{1A}$, $H\phi_{1B}$, $H\phi_{2A}$, $H\phi_{2B}$, $LH\phi_1$, GND – V_L	–0.3 to +13	V	
Between input clock pins	Potential difference between vertical clock input pins	to +13	V	*1
	$H\phi_{1A}$, $H\phi_{1B}$ – $H\phi_{2A}$, $H\phi_{2B}$	–5 to +5	V	
	$H\phi_{1A}$, $H\phi_{1B}$, $H\phi_{2A}$, $H\phi_{2B}$ – $V\phi_{4B}$, $V\phi_{HLD}$	–13 to +13	V	
Storage temperature		–30 to +80	℃	
Operating temperature		–10 to +60	℃	

*1 Guaranteed up to 25V when the clock width < 10μs and the clock duty factor < 0.1%.

Bias Conditions

Item	Symbol	Min.	Typ.	Max.	Unit	Remarks
Supply voltage	V_{DD}	14.55	15.0	15.45	V	
Protective transistor bias	V_L	*1			V	
Substrate clock	ϕSUB	*2				
Reset gate clock	ϕRG	*2				

*1 For the V_L setting, use the V_{VL} voltage of the vertical clock waveform or the same voltage as the V_L power supply of the V driver.

*2 Do not apply a DC bias to the substrate clock and reset gate clock pins, because a DC bias is generated internally.

DC Characteristics

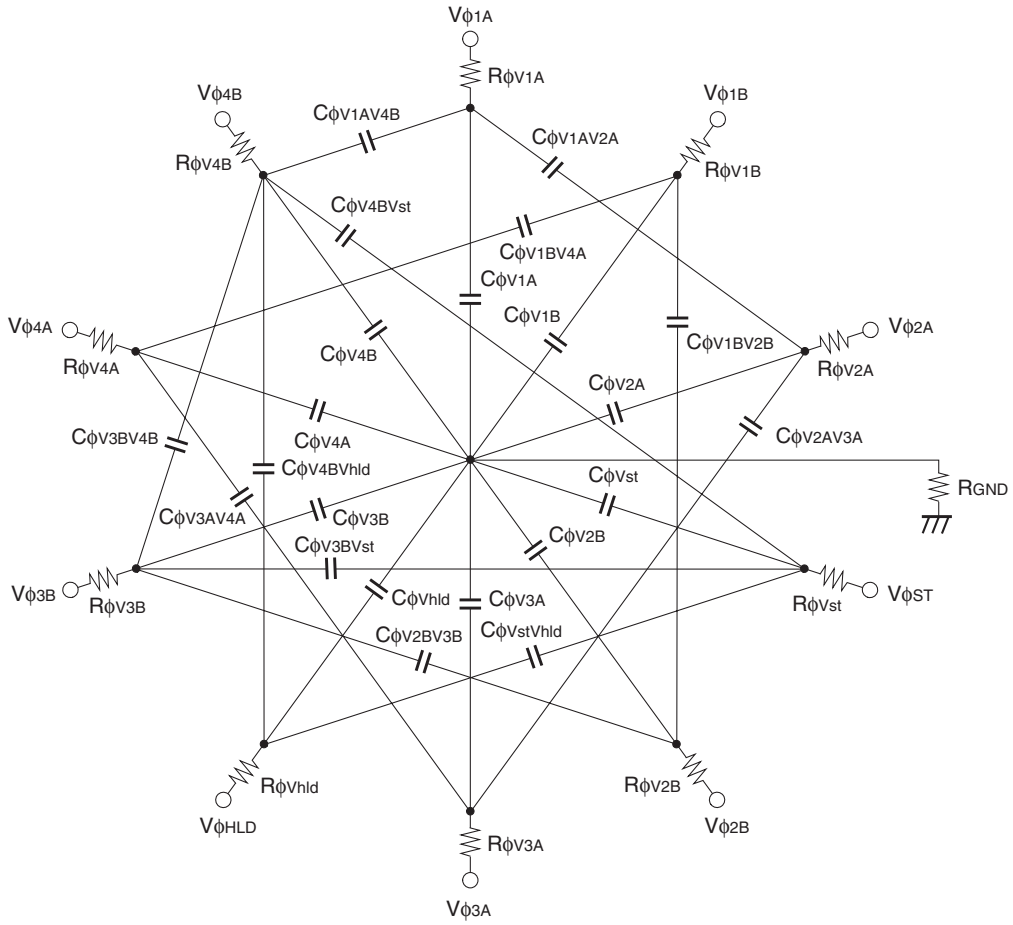
Item	Symbol	Min.	Typ.	Max.	Unit	Remarks
Supply current	I_{DD}		10.0		mA	

Clock Voltage Conditions

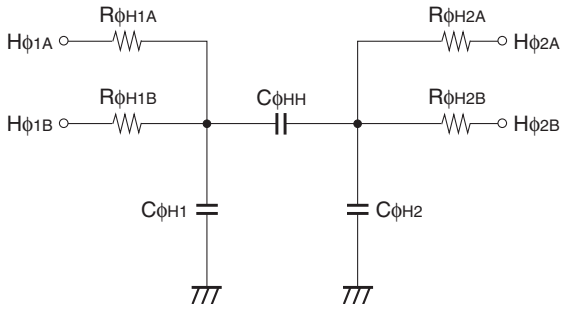
Item	Symbol	Min.	Typ.	Max.	Unit	Waveform diagram	Remarks
Readout clock voltage	V_{VT}	14.55	15.0	15.45	V	1	
Vertical transfer clock voltage	V_{VH2}, V_{VH3}	–0.05	0	0.05	V	2	$V_{VH} = (V_{VH2} + V_{VH3})/2$
	V_{VH1}, V_{VH4}, V_{VHSTR}, V_{VHHLD}	–0.2	0	0.05	V	2	
	V_{VL1}, V_{VL2}, V_{VL3}, V_{VL4}, V_{VLSTR}, V_{VLHLD}	–8.8	–8.5	–8.2	V	2	$V_{VL} = (V_{VL1} + V_{VL4})/2$
	$V_{\phi V}$	8.0	8.5	8.85	V	2	$V_{\phi V} = V_{VHn} – V_{VLn}$ (n = 1 to 4)
	$V_{VH1} – V_{VH}$	–0.25		0.1	V	2	
	$V_{VH4} – V_{VH}$	–0.25		0.1	V	2	
	V_{VHH}			0.5	V	2	High-level coupling
	V_{VHL}			0.5	V	2	High-level coupling
	V_{VLH}			0.5	V	2	Low-level coupling
	V_{VLL}			0.5	V	2	Low-level coupling
Horizontal transfer clock voltage	$V_{\phi H}$	3.4	3.6	3.8	V	3	
	V_{HL}	–0.05	0	0.05	V	3	
	V_{CR}	$V_{\phi H}/2$			V	3	Cross-point voltage
Reset gate clock voltage	$V_{\phi RG}$	3.4	3.6	3.8	V	4	
	$V_{RGLH} – V_{RGLL}$			0.4	V	4	Low-level coupling
	$V_{RGL} – V_{RGLm}$			0.5	V	4	Low-level coupling
Substrate clock voltage	$V_{\phi SUB}$	22.5	23.5	24.5	V	5	

Clock Equivalent Circuit Constants

Item	Symbol	Min.	Typ.	Max.	Unit	Remarks
Capacitance between vertical transfer clock and GND	$C_{\phi V1A}$, $C_{\phi V1B}$		1200		pF	
	$C_{\phi V2A}$, $C_{\phi V2B}$		2700		pF	
	$C_{\phi V3A}$, $C_{\phi V3B}$		680		pF	
	$C_{\phi V4A}$, $C_{\phi V4B}$		1800		pF	
	$C_{\phi Vst}$, $C_{\phi Vhld}$		1		pF	
Capacitance between vertical transfer clocks	$C_{\phi V1AV2A}$, $C_{\phi V1BV2B}$		220		pF	
	$C_{\phi V1AV4B}$, $C_{\phi V1BV4A}$		47		pF	
	$C_{\phi V2AV3A}$, $C_{\phi V2BV3B}$		220		pF	
	$C_{\phi V3AV4A}$, $C_{\phi V3BV4B}$		390		pF	
	$C_{\phi V3BVst}$, $C_{\phi V4BVhld}$		47		pF	
	$C_{\phi V4BVst}$, $C_{\phi VstVhld}$		47		pF	
Capacitance between horizontal transfer clock and GND	$C_{\phi H1}$		32		pF	
	$C_{\phi H2}$		30		pF	
Capacitance between horizontal transfer clocks	$C_{\phi HH}$		56		pF	
Capacitance between reset gate clock and GND	$C_{\phi RG}$		1		pF	
Capacitance between substrate clock and GND	$C_{\phi SUB}$		330		pF	
Capacitance between horizontal final stage transfer clock and GND	$C_{\phi LH1}$		1		pF	
Vertical transfer clock series resistance	$R_{\phi V1A}$, $R_{\phi V1B}$, $R_{\phi V4A}$, $R_{\phi V4B}$, $R_{\phi Vst}$, $R_{\phi Vhld}$		39		Ω	
	$R_{\phi V2A}$, $R_{\phi V2B}$, $R_{\phi V3A}$, $R_{\phi V3B}$		82		Ω	
Vertical transfer clock ground resistance	R_{GND}		15		Ω	
Horizontal transfer clock series resistance	$R_{\phi H1A}$, $R_{\phi H1B}$		18		Ω	
	$R_{\phi H2A}$, $R_{\phi H2B}$		16		Ω	
Substrate clock series resistance	$R_{\phi SUB}$		300		kΩ	



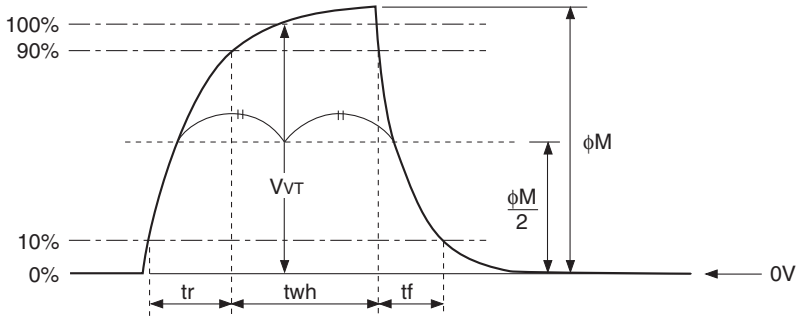
Vertical transfer clock equivalent circuit



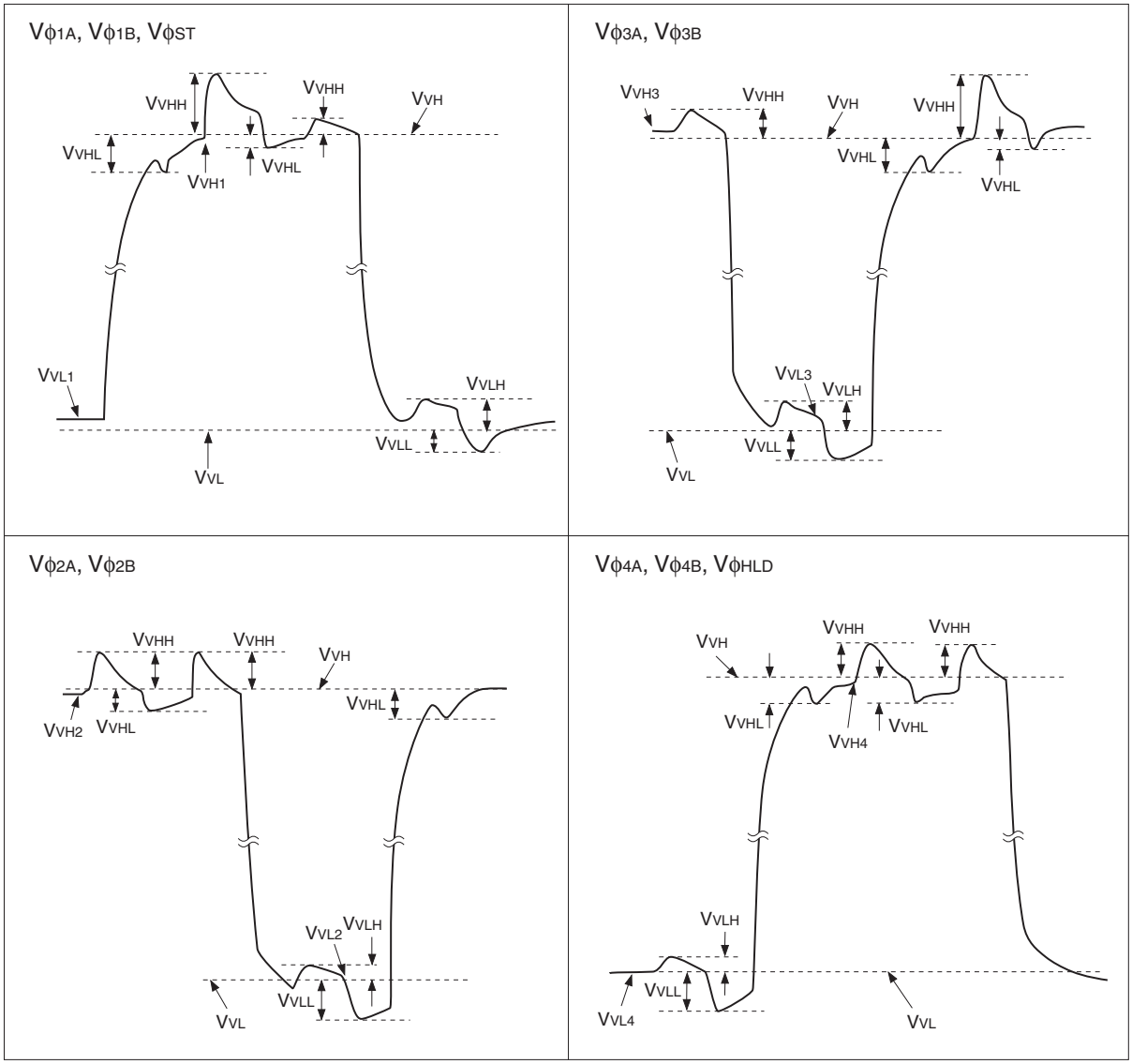
Horizontal transfer clock equivalent circuit

Drive Clock Waveform Conditions

1. Readout clock waveform

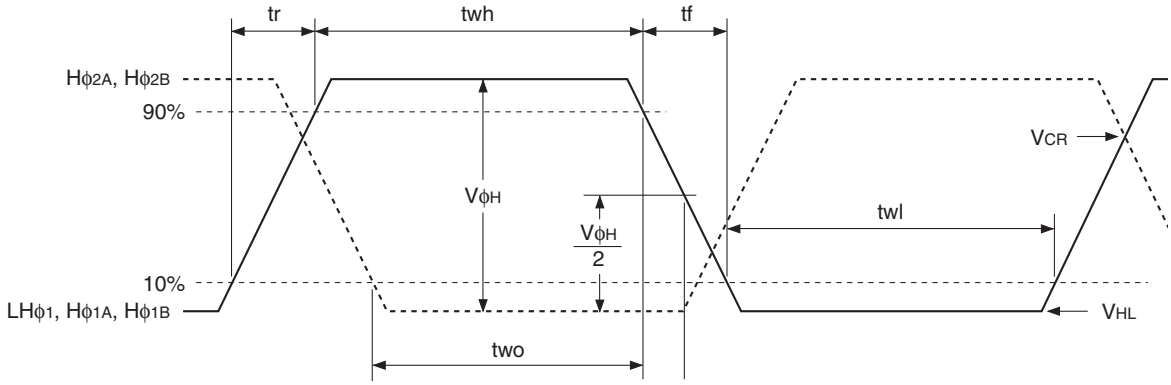


2. Vertical transfer clock waveform



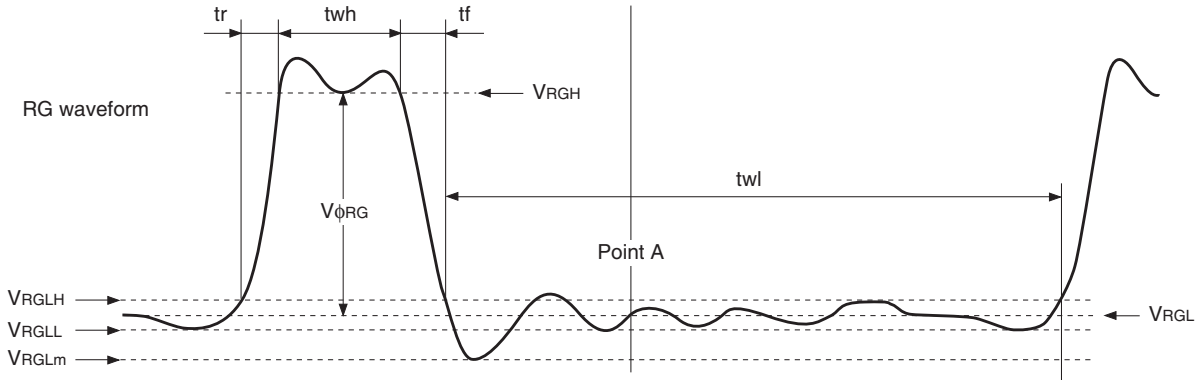
$V_{VH} = (V_{VH2} + V_{VH3})/2$
$V_{VL} = (V_{VL1} + V_{VL4})/2$
$V_{\phi V} = V_{VHn} – V_{VLn}$ (n = 1 to 4)

3. Horizontal transfer clock waveform



V_{CR} is the cross-point voltage of the horizontal transfer clocks Hϕ1A, Hϕ1B, LHϕ1 and Hϕ2A, Hϕ2B waveforms that is on the Hϕ1A, Hϕ1B, LHϕ1 rise side.
"two" is the overlapped period with twh and twl of the horizontal transfer clocks Hϕ1A, Hϕ1B, LHϕ1 and Hϕ2A, Hϕ2B.

4. Reset gate clock waveform



V_{RGLH} is the maximum value and V_{RGLL} is the minimum value of the coupling waveform during the period from Point A in the above diagram until the rising edge of RG.
In addition, V_{RGL} is the average value of V_{RGLH} and V_{RGLL}.

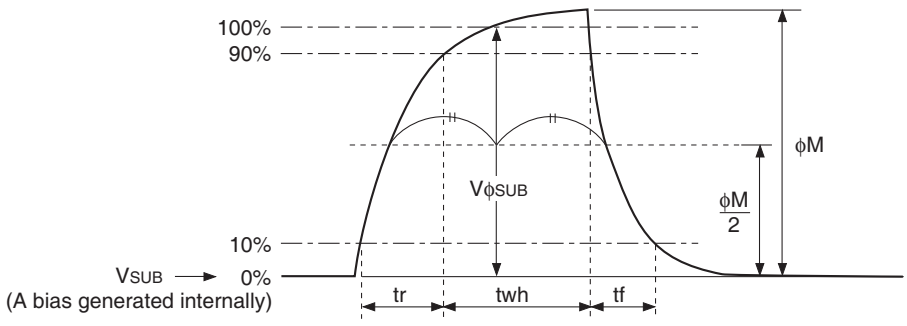
$$V_{RGL} = (V_{RGLH} + V_{RGLL})/2$$

Assuming V_{RGH} is the minimum value during the interval twh, then;

$$V_{\phi RG} = V_{RGH} - V_{RGL}$$

V_{RGLm} is the negative overshoot level during the falling edge of RG.

5. Substrate clock waveform



Clock Switching Characteristics

(Horizontal drive frequency: 36.0MHz)

Item	Symbol	twh			twl			tr			tf			Unit	Remarks
		Min.	Typ.	Max.	Min.	Typ.	Max.	Min.	Typ.	Max.	Min.	Typ.	Max.		
Readout clock	VT	1.52	1.72						0.5			0.5		μs	During readout
Vertical transfer clock	Vφ1A, Vφ1B, Vφ2A, Vφ2B, Vφ3A, Vφ3B, Vφ4A, Vφ4B, VφST, VφHLD										15		250	ns	When using CXD3400N
Horizontal transfer clock	LHφ1, Hφ1A, Hφ1B	8	9		8	9			5	6		5	6	ns	When driving at 3.6V during imaging, tf ≥ tr – 2ns
	Hφ2A, Hφ2B	8	9		8	9			5	6		5	6		
Reset gate clock	φRG	4	5.5			17.2			2			3		ns	
Substrate clock	φSUB	0.9	1.8							0.25			0.25	μs	When draining charge

Item	Symbol	two			Unit	Remarks
		Min.	Typ.	Max.		
Horizontal transfer clock	LHφ1, Hφ1A, Hφ1B, Hφ2A, Hφ2B	8	9		ns	

Spectral Sensitivity Characteristics

(excludes lens characteristics and light source characteristics)

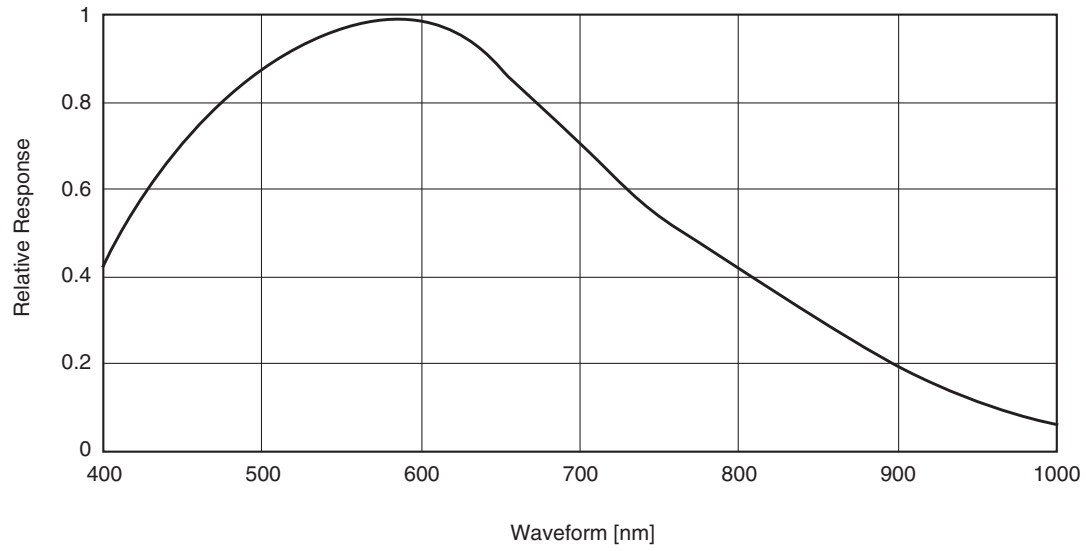


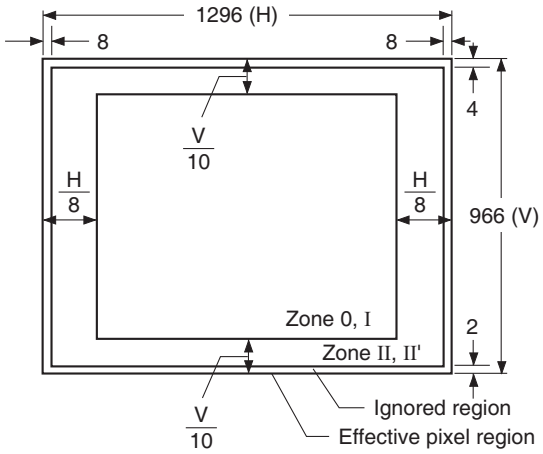
Image Sensor Characteristics (Center cut-out drive, 30 frame/s)

(Ta = 25℃)

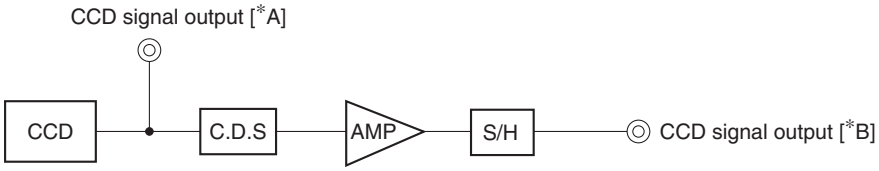
Item	Symbol	Min.	Typ.	Max.	Unit	Measurement method	Remarks
Sensitivity 1	S1	300	380		mV	1	1/30s accumulation
Sensitivity 2	S2	1000	1500		mV	2	1/30s accumulation
Saturation signal	Vsat	350			mV	3	Ta = 60℃
Smear	Sm		–104	–96	dB	4	
Video signal shading	SH			20	%	5	Zone 0 and I
				25	%	5	Zone 0 to II'
Dark signal	Vdt			2	mV	6	Ta = 60℃, 1/30s accumulation
Dark signal shading	ΔVdt			1	mV	7	Ta = 60℃, 1/30s accumulation*1
Lag	Lag			0.5	%	8	

*1 Excludes vertical dark signal shading caused by the vertical register high-speed transfer.

Zone Definition of Video Signal Shading



Measurement System



Note) Adjust the amplifier gain so that the gain between [* A] and [* B] equals 1.

Image Sensor Characteristics Measurement Method

Measurement conditions

1. In the following measurements, the device drive conditions are at the typical values of the bias and clock voltage conditions.

2. In the following measurements, spot pixels are excluded and, unless otherwise specified, the optical black (OB) level is used as the reference for the signal output, and the value measured at point [*B] of the measurement system is used.

Definition of Standard Imaging Conditions

◆ Standard imaging condition I:
Use a pattern box (luminance: 706cd/m^2, color temperature of 3200K halogen source) as a subject. (Pattern for evaluation is not applicable.) Use a testing standard lens with CM500S (t = 1.0mm) as an IR cut filter and image at F8. The luminous intensity to the sensor receiving surface at this point is defined as the standard sensitivity testing luminous intensity.

◆ Standard imaging condition II:
This indicates the standard imaging condition I with the IR cut filter removed.

◆ Standard imaging condition III:
Image a light source (color temperature of 3200K) with a uniformity of brightness within 2% at all angles. Use a testing standard lens with CM500S (t = 1.0mm) as an IR cut filter. The luminous intensity is adjusted to the value indicated in each testing item by the lens diaphragm.

1. Sensitivity 1
Set the measurement condition to the standard imaging condition I. After setting the electronic shutter mode with a shutter speed of 1/100s, measure the signal output (V_{S1}) at the center of the screen, and substitute the value into the following formula.

$S1 = V_{S1} \times (100/30)$ [mV]

2. Sensitivity 2
Set the measurement condition to the standard imaging condition II. After setting the electronic shutter mode with a shutter speed of 1/500s, measure the signal output (V_{S2}) at the center of the screen, and substitute the value into the following formula.

$S2 = V_{S2} \times (500/30)$ [mV]

3. Saturation signal
Set the measurement condition to the standard imaging condition III. After adjusting the luminous intensity to 10 times the intensity with the average value of the signal output, 150mV, measure the minimum value of the signal output.

4. Smear
Set the measurement condition to the standard imaging condition III. With the lens diaphragm at F5.6 to F8, adjust the luminous intensity to 500 times the intensity with the average value of the signal output, 150mV. When the readout clock is stopped and the charge drain is executed by the electronic shutter at the respective H blankings, measure the maximum value (VSm) of the signal output, and substitute the value into the following formula.

$Sm = 20 \times \log ((VSm/150) \times (1/500) \times (1/10))$ [dB] (1/10V method conversion value)

5. Video signal shading
   Set the measurement condition to the standard imaging condition III. With the lens diaphragm at F5.6 to F8, adjust the luminous intensity so that the average value of the signal output is 150mV. Then measure the maximum value (Vmax) and the minimum value (Vmin) of the signal output, and substitute the values into the following formula.

   SH = (Vmax – Vmin)/150 × 100 [%]

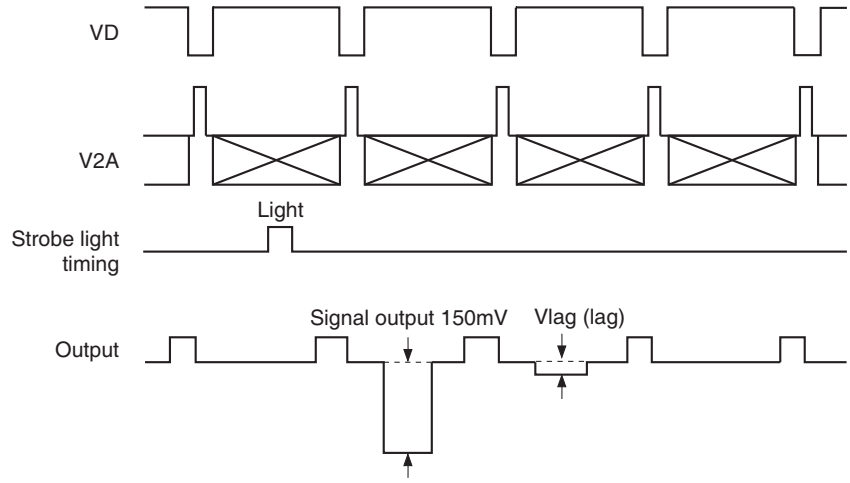
6. Dark signal
   Measure the average value (Vdt) of the signal output with the device ambient temperature of 60°C and the device in the light-obstructed state, using the horizontal idle transfer level as the reference.

7. Dark signal shading
   After the measurement item 6, measure the maximum value (Vdmax) and the minimum value (Vdmin) of the dark signal output, and substitute the values into the following formula.

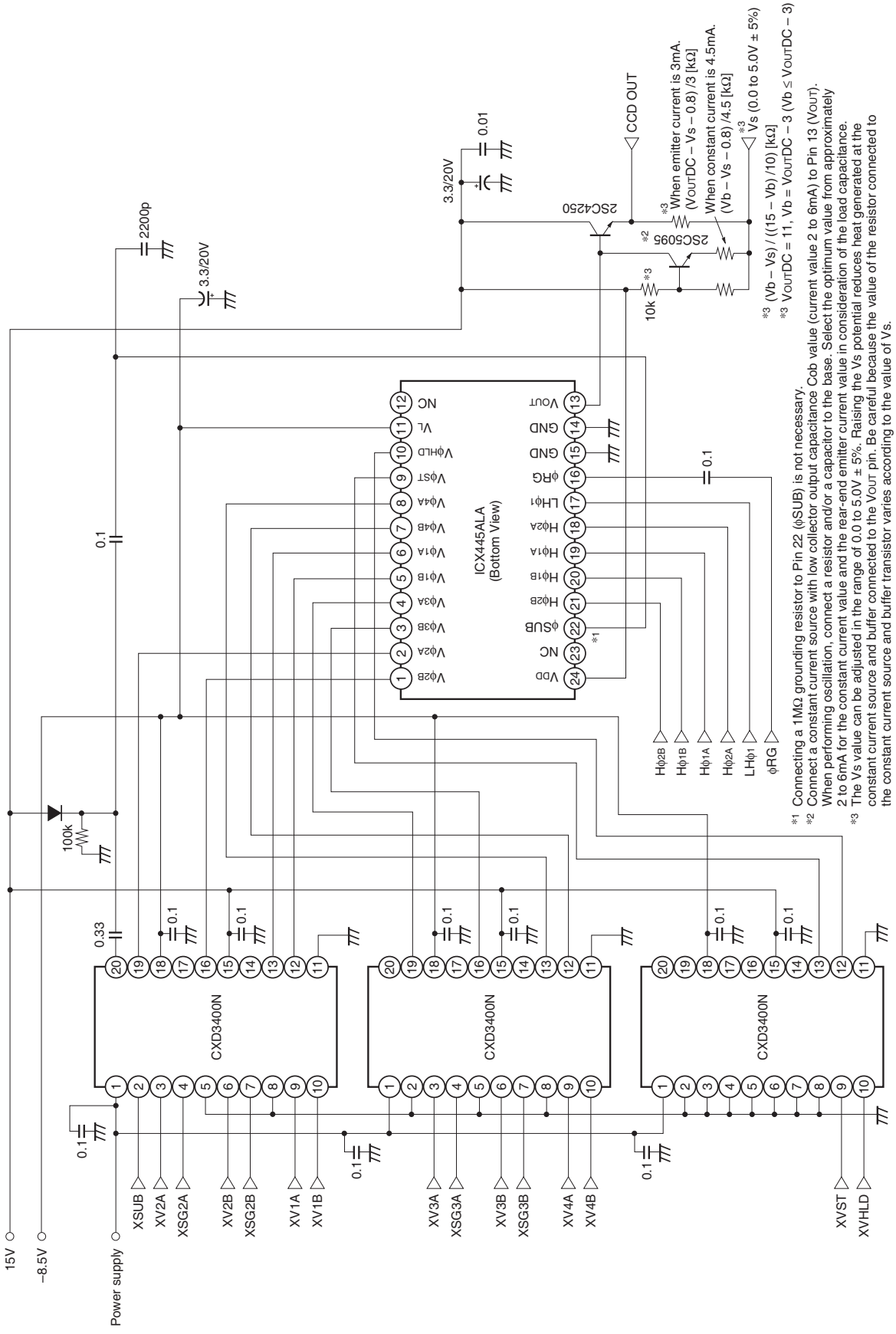
   ΔVdt = Vdmax – Vdmin [mV]

8. Lag
   Adjust the signal output value generated by the strobe light to 150mV. After setting the strobe light so that it strobes with the following timing, measure the residual signal level (Vlag), and substitute the value into the following formula.

   Lag = (Vlag/150) × 100 [%]

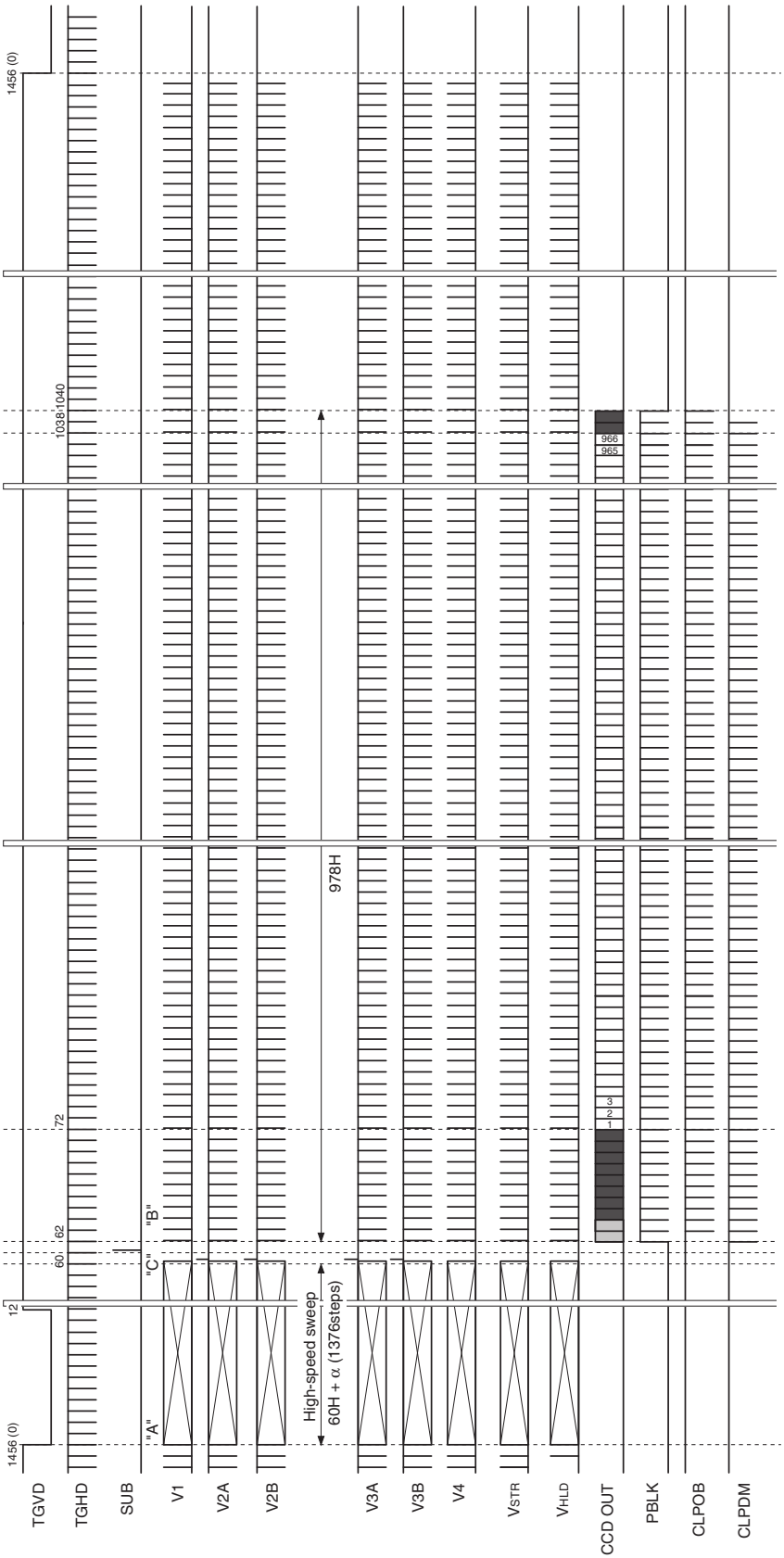


Drive Circuit

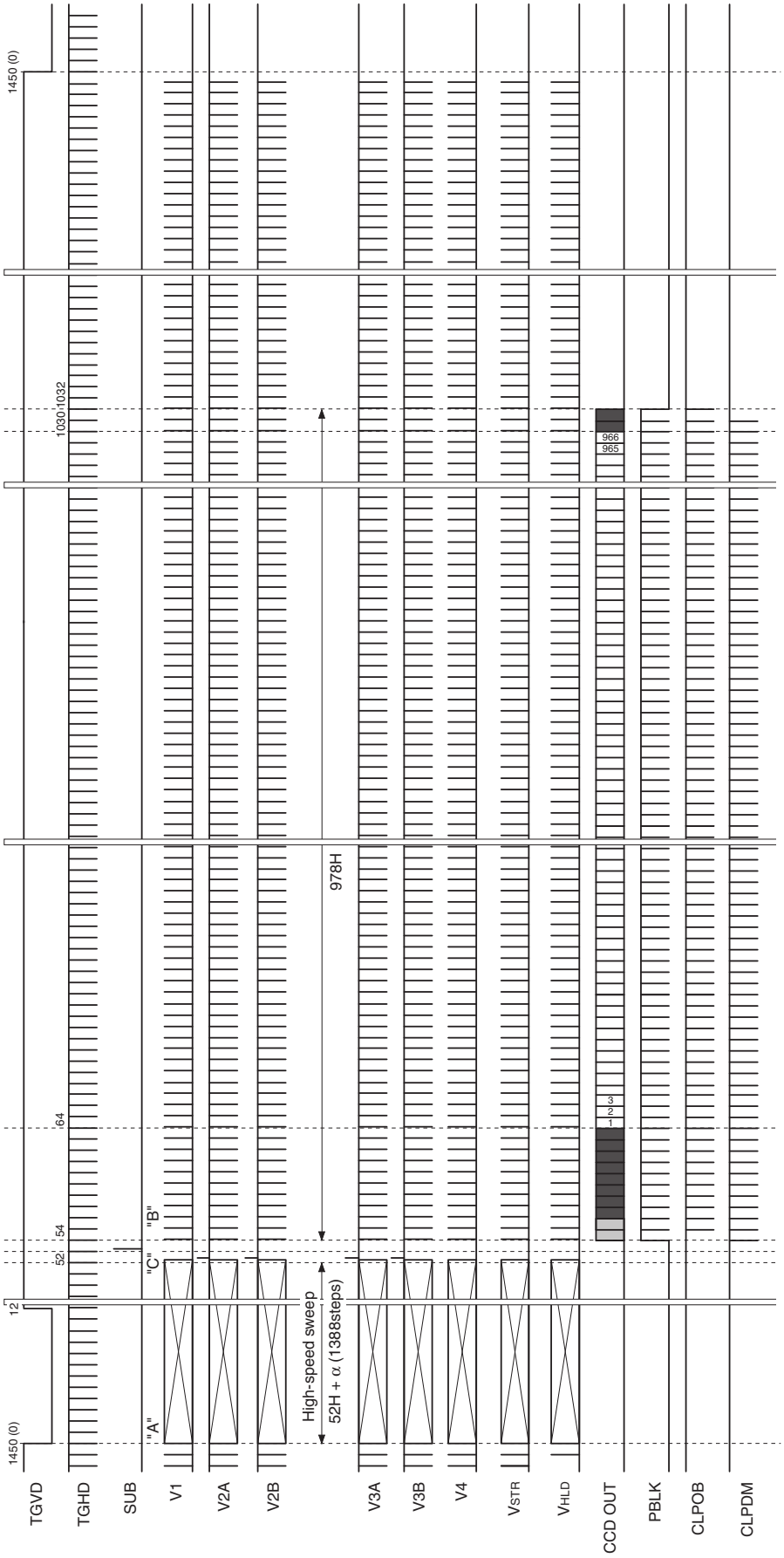


Drive Timing Chart

All-pixel Scan Mode (15 frame/s) Vertical Direction

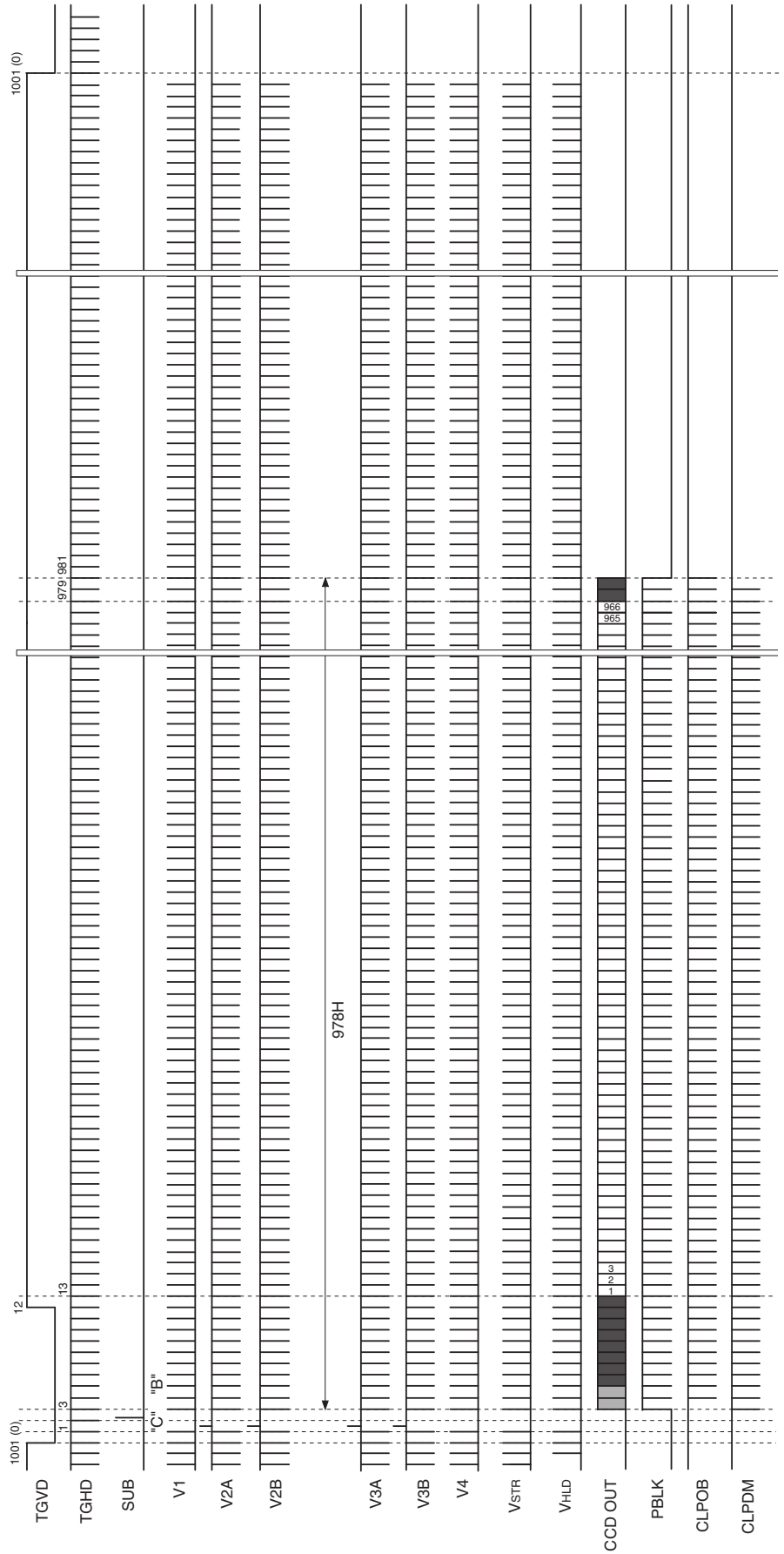


All-pixel Scan Mode (12.5 frame/s) Vertical Direction



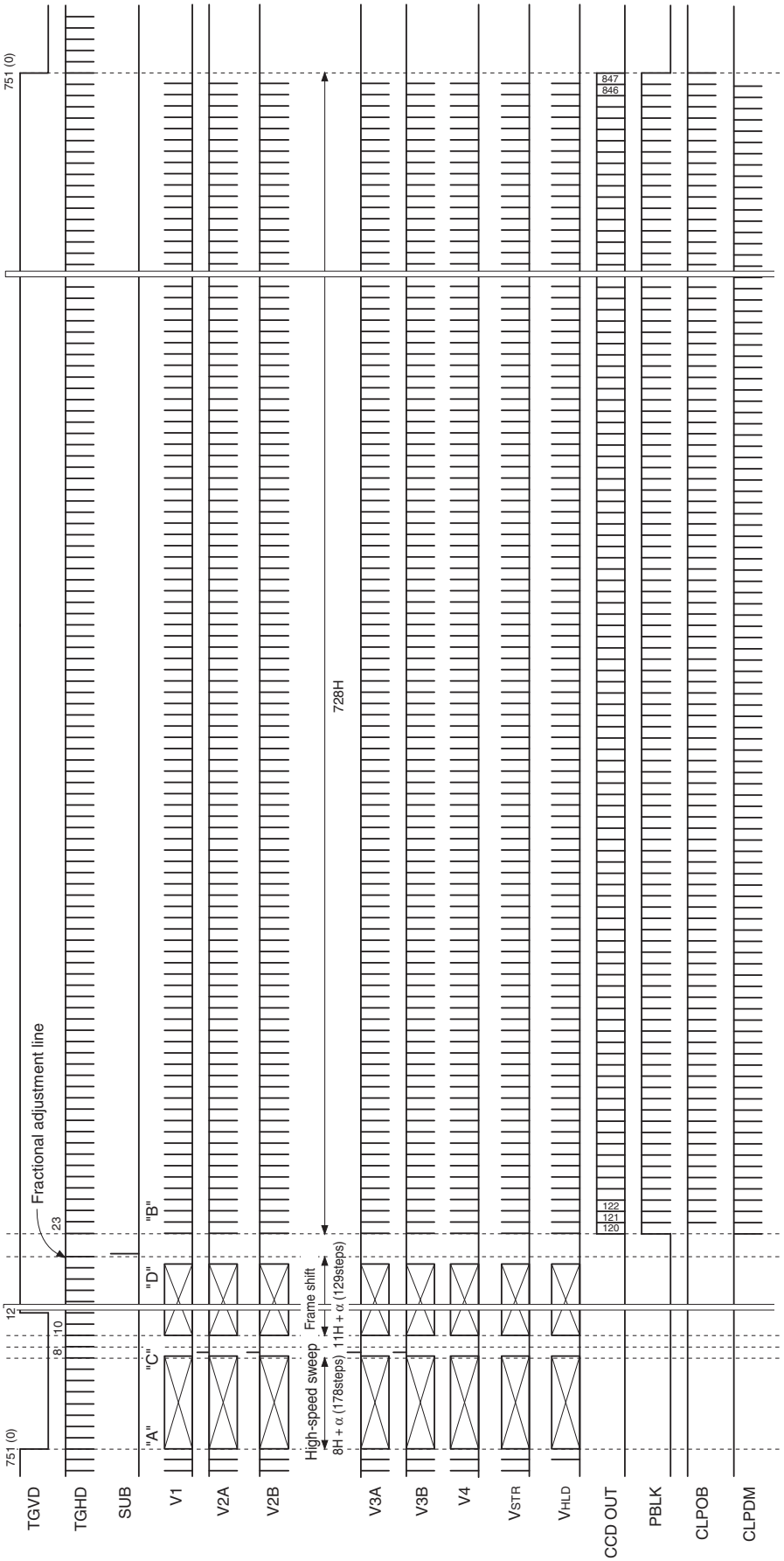
* TGVD in this chart is noted at 1450H (1H: 1600clocks). (1clock = 29.0MHz)

All-pixel Scan Mode (22.5 frame/s) Vertical Direction



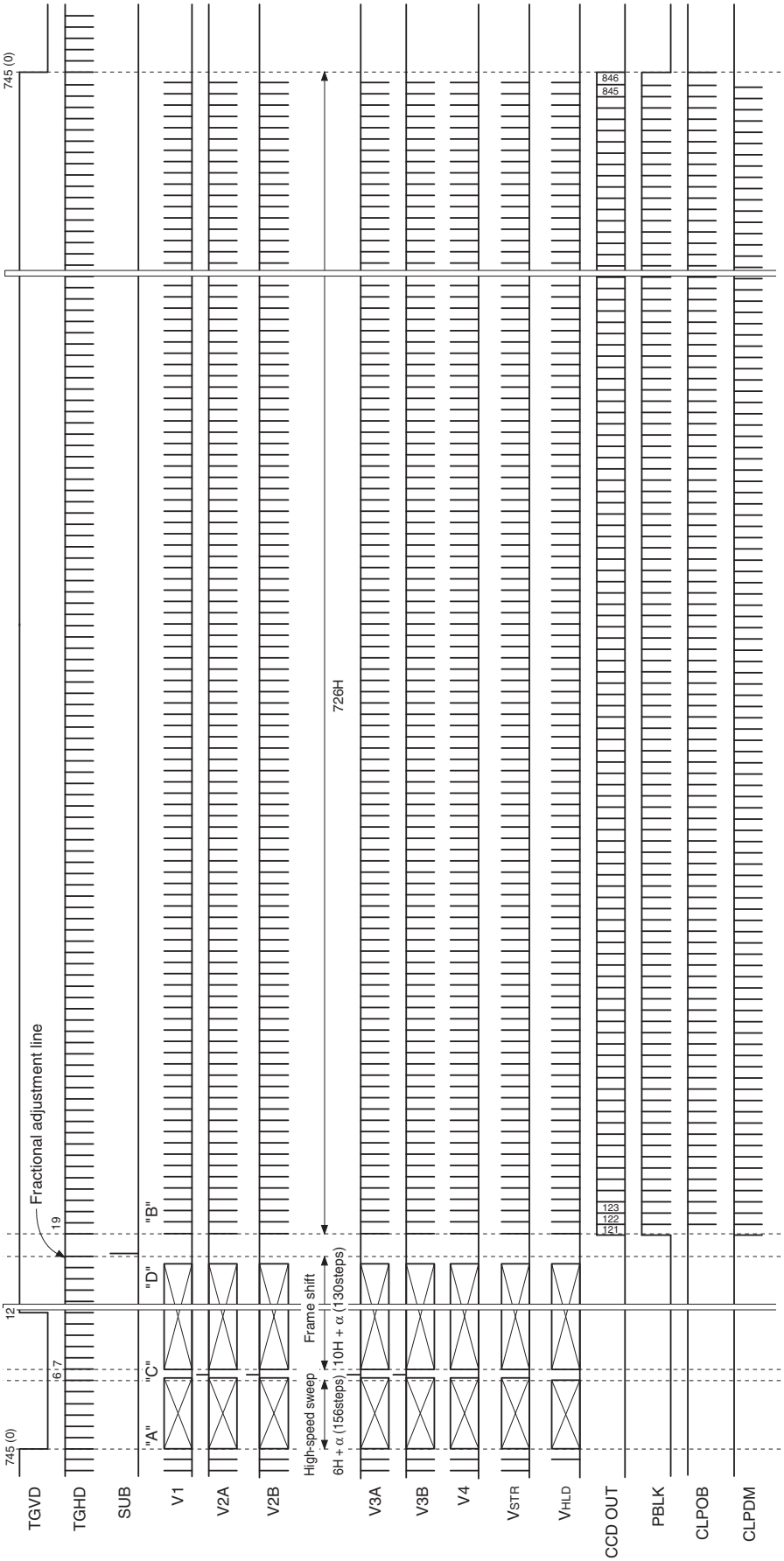
* TGVD in this chart is noted at 1001H (1H: 1600clocks). (1clock = 36.0MHz)

Center Cut-out Mode (30 frame/s) Vertical Direction



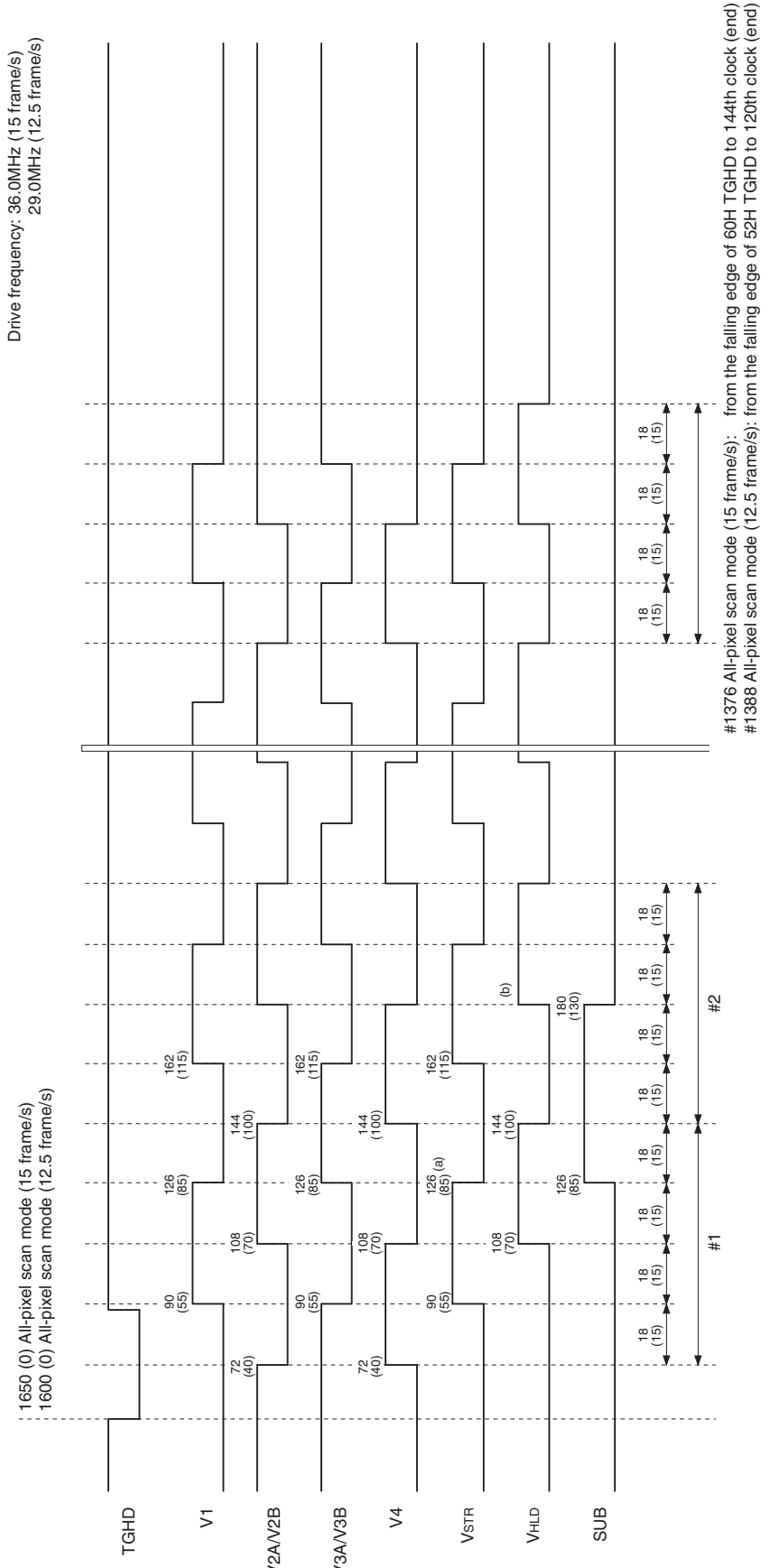
* TGVD in this chart is noted at 750H (1H: 1598clocks) + 1H (2700clocks: fractional adjustment line). (1clock = 36.0MHz)

Center Cut-out Mode (25 frame/s) Vertical Direction



* TGVD in this chart is noted at 744H (1H: 1556clocks) + 1H (2336clocks: fractional adjustment line). (1clock = 29.0MHz)

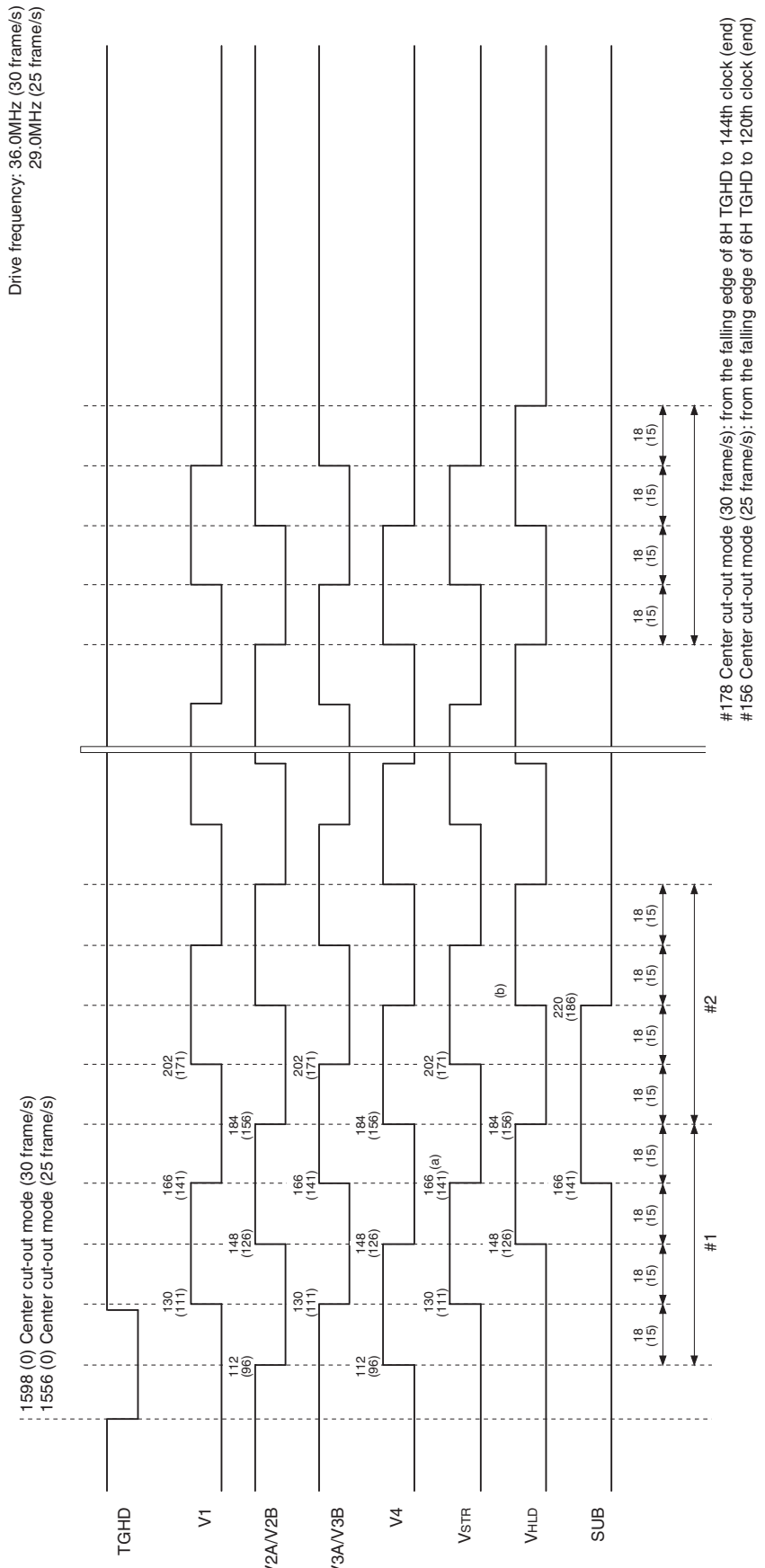
All-pixel Scan Mode (15 frame/s, 12.5 frame/s)
Horizontal Direction High-speed Sweep Block [A]



* Synchronize the rising edge of SUB with the first falling edge of V_{STR} (a) counting from the falling edge of TGHD, and synchronize the falling edge of SUB with the first rising edge of V_{HLD} (b) counting from (a).

* The numbers at the output pulse transition points indicate the count at the rising edge of the clock from the falling edge of TGHD. The numbers on the upper level are for 36.0MHz, and the numbers in parentheses on the lower level are for 29.0MHz.

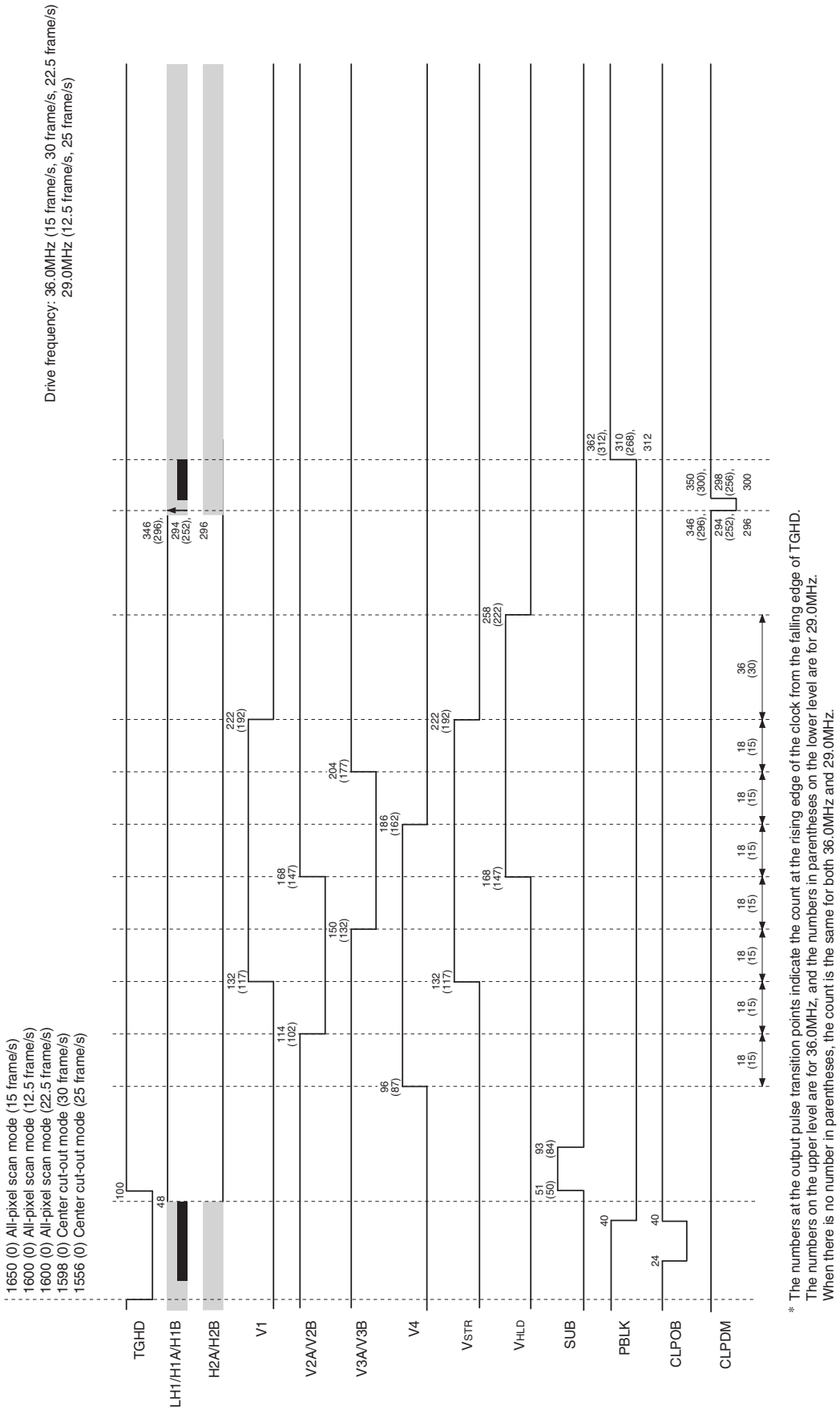
Center Cut-out Mode (30 frame/s, 25 frame/s)
Horizontal Direction High-speed Sweep Block [A]



* Synchronize the rising edge of SUB with the first falling edge of VSTR (a) counting from the falling edge of TGHD, and synchronize the falling edge of SUB with the first rising edge of VHLD (b) counting from (a).

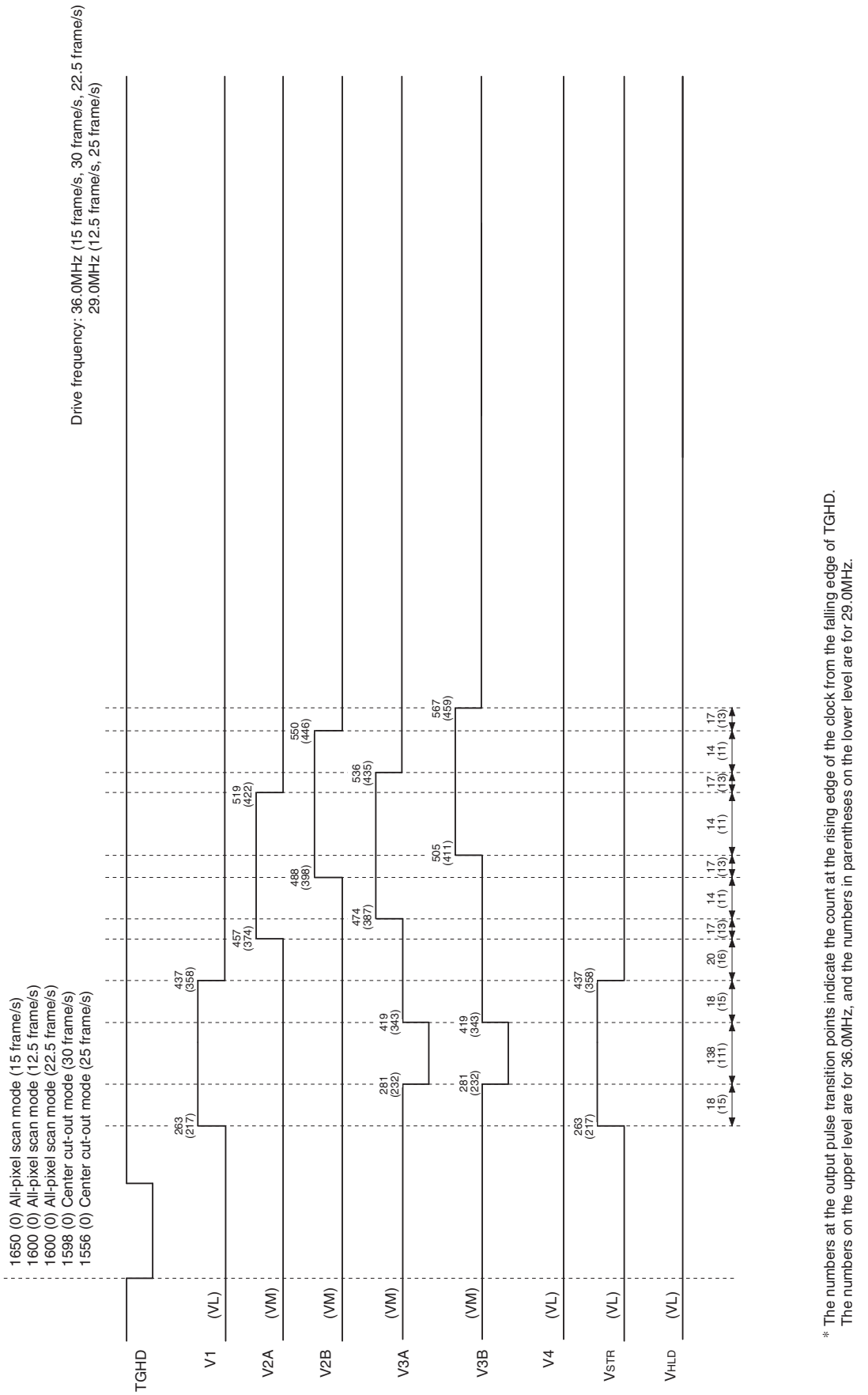
* The numbers at the output pulse transition points indicate the count at the rising edge of the clock from the falling edge of TGHD. The numbers on the upper level are for 36.0MHz, and the numbers in parentheses on the lower level are for 29.0MHz.

All-pixel Scan Mode (15 frame/s, 12.5 frame/s, 22.5 frame/s)/Center Cut-out Mode (30 frame/s, 25 frame/s)
Horizontal Direction Normal Transfer Block [B]



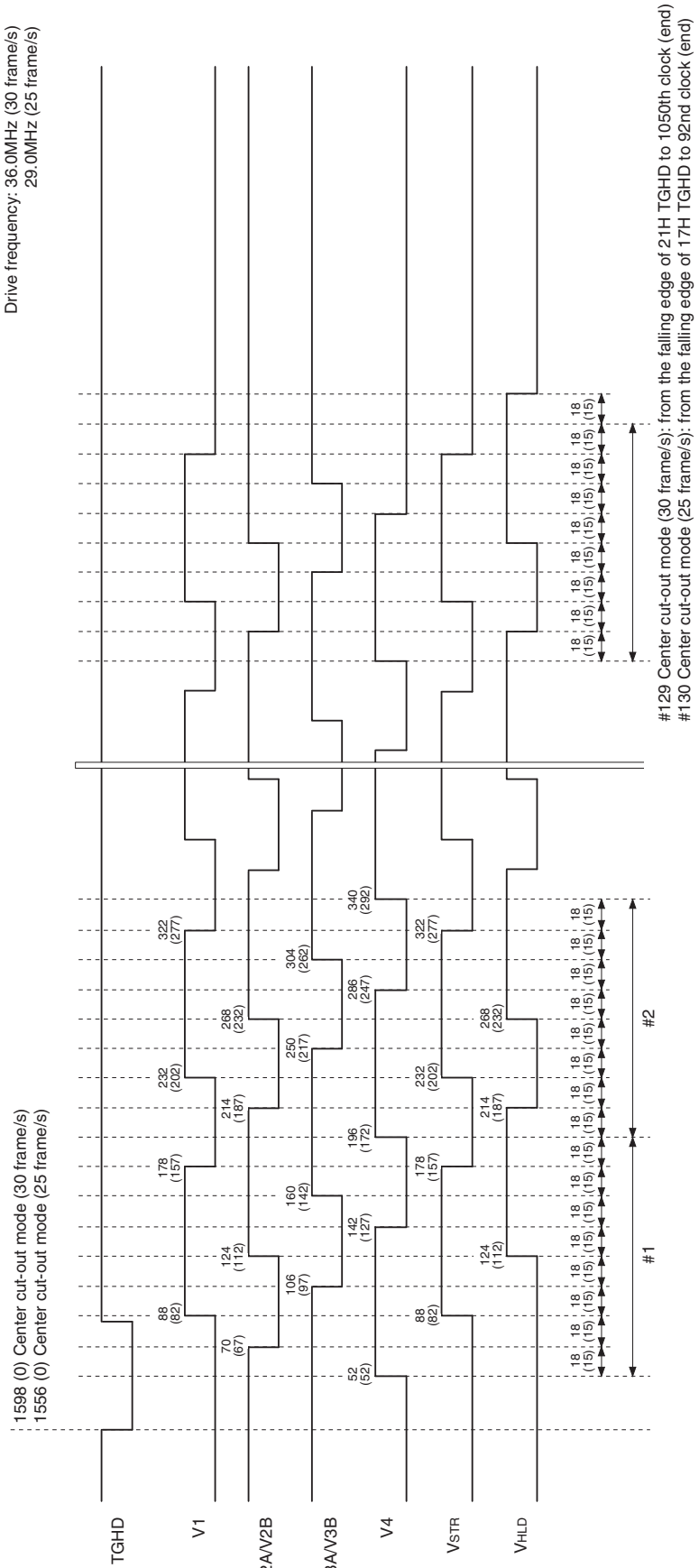
* The numbers at the output pulse transition points indicate the count at the rising edge of the clock from the falling edge of TGHD.
The numbers on the upper level are for 36.0MHz, and the numbers in parentheses on the lower level are for 29.0MHz.
When there is no number in parentheses, the count is the same for both 36.0MHz and 29.0MHz.

All-pixel Scan Mode (15 frame/s, 12.5 frame/s, 22.5 frame/s)/Center Cut-out Mode (30 frame/s, 25 frame/s)
Horizontal Direction Readout Block [C]



* The numbers at the output pulse transition points indicate the count at the rising edge of the clock from the falling edge of TGHD.
The numbers on the upper level are for 36.0MHz, and the numbers in parentheses on the lower level are for 29.0MHz.

Center Cut-out Mode (30 frame/s, 25 frame/s)
Horizontal Direction Frame Shift Block [D]



* SUB pulse generation is prohibited during the frame shift period.

* The numbers at the output pulse transition points indicate the count at the rising edge of the clock from the falling edge of TGHD.
The numbers on the upper level are for 36.0MHz, and the numbers in parentheses on the lower level are for 29.0MHz.

Notes On Handling

1. Static charge prevention

   Image sensors are easily damaged by static discharge. Before handling be sure to take the following protective measures.

   (1) Either handle bare handed or use non-chargeable gloves, clothes or material. Also use conductive shoes.

   (2) Use a wrist strap when handling directly.

   (3) Install grounded conductive mats on the floor and working table to prevent the generation of static electricity.

   (4) Ionized air is recommended for discharge when handling image sensors.

   (5) For the shipment of mounted boards, use boxes treated for the prevention of static charges.

2. Soldering

   (1) Make sure the temperature of the upper surface of the seal glass resin adhesive portion of the package does not exceed 80℃.

   (2) Solder dipping in a mounting furnace causes damage to the glass and other defects. Use a 30W soldering iron with a ground wire and solder each pin in 2 seconds or less. For repairs and remount, cool sufficiently.

   (3) To dismount an image sensor, do not use solder suction equipment. When using an electric desoldering tool, use a thermal controller of the zero-cross On/Off type and connect it to ground.

3. Protection from dust and dirt

   Image sensors are packed and delivered with care taken to protect the element glass surfaces from harmful dust and dirt. Clean glass surfaces with the following operations as required before use.

   (1) Perform all lens assembly and other work in a clean room (class 1000 or less).

   (2) Do not touch the glass surface with hand and make any object contact with it. If dust or other is stuck to a glass surface, blow it off with an air blower. (For dust stuck through static electricity, ionized air is recommended.)

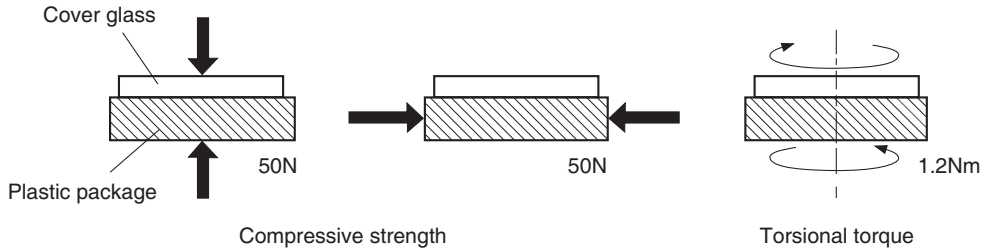
   (3) Clean with a cotton bud and ethyl alcohol if grease stained. Be careful not to scratch the glass.

   (4) Keep in a dedicated case to protect from dust and dirt. To prevent dew condensation, preheat or precool when moving to a room with great temperature differences.

   (5) When a protective tape is applied before shipping, remove the tape applied for electrostatic protection just before use. Do not reuse the tape.

4. Installing (attaching)

   (1) Remain within the following limits when applying a static load to the package. Do not apply any load more than 0.7mm inside the outer perimeter of the glass portion, and do not apply any load or impact to limited portions. (This may cause cracks in the package.)



   (2) If a load is applied to the entire surface by a hard component, bending stress may be generated and the package may fracture, etc., depending on the flatness of the bottom of the package. Therefore, for installation, use either an elastic load, such as a spring plate, or an adhesive.

   (3) The adhesive may cause the marking on the rear surface to disappear, especially in case the regulated voltage value is indicated on the rear surface. Therefore, the adhesive should not be applied to this area, and indicated values should be transferred to the other locations as a precaution.

(4) The notch of the package is used for directional index, and that can not be used for reference of fixing. In addition, the cover glass and seal resin may overlap with the notch of the package.

(5) If the lead bend repeatedly and the metal, etc., clash or rub against the package, dust may be generated by the fragments of resin.

(6) Acrylate anaerobic adhesives are generally used to attach image sensors. In addition, cyanoacrylate instantaneous adhesives are sometimes used jointly with acrylate anaerobic adhesives to hold the image sensor in place until the adhesive completely hardens. (reference)

5. Others

(1) Do not expose to strong light (sun rays) for long periods, as color filters will be discolored. When high luminance objects are imaged with the exposure level controlled by the electronic iris, the luminance of the image-plane may become excessive and discoloration of the color filters may be accelerated. In such a case, arrangements such as using an automatic iris with the imaging lens or automatically closing the shutter during power-off are advisable. For continuous use under harsh conditions exceeding the normal conditions of use, consult your Sony representative.

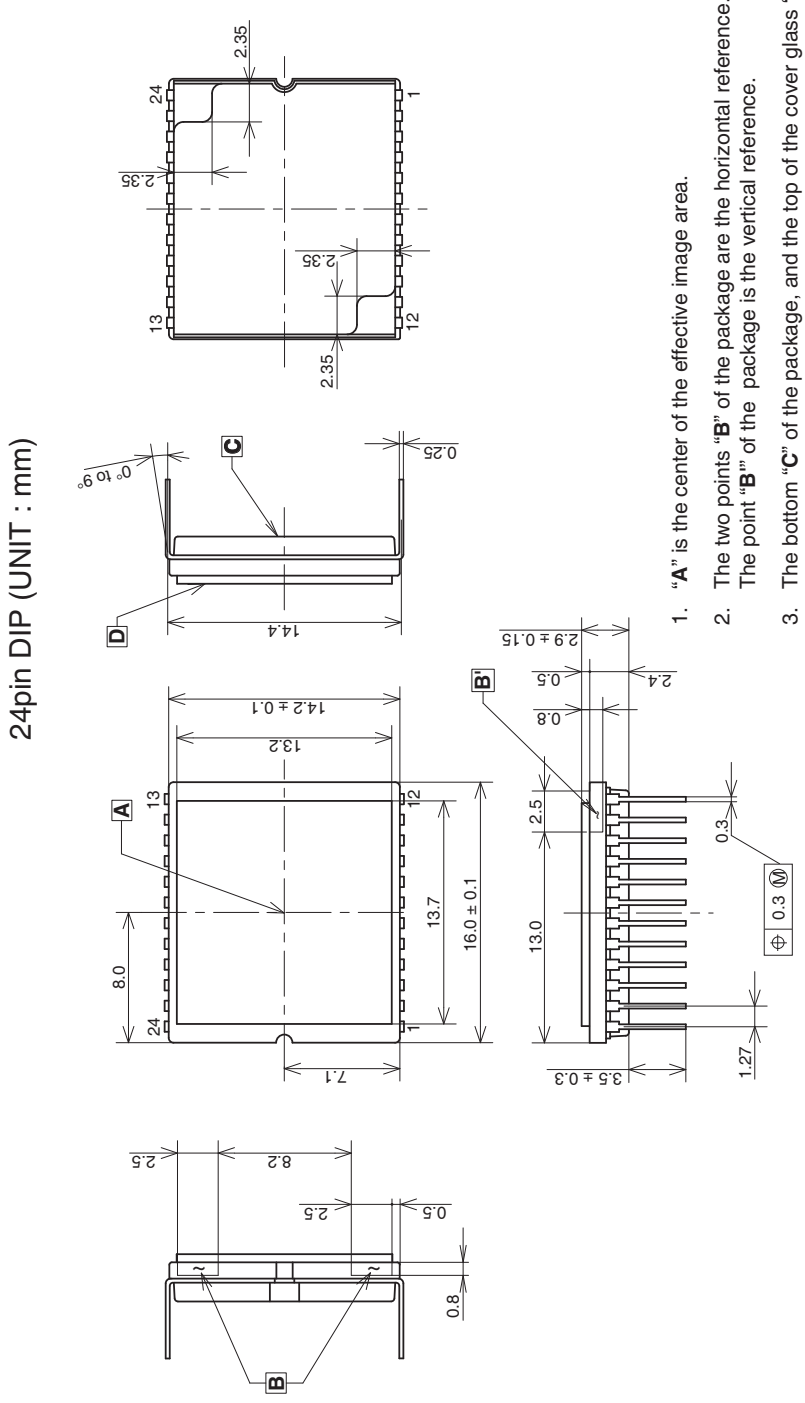
(2) Exposure to high temperature or humidity will affect the characteristics. Accordingly avoid storage or use in such conditions.

(3) Brown stains may be seen on the bottom or side of the package. But this does not affect the characteristics.

(4) This image sensor has sensitivity in the near infrared area. Its focus may not match in the same condition under visible light/near infrared light because of aberration. Incident light component of long wavelength which transmits the silicon substrate may have bad influence upon image.

Package Outline

(Unit: mm)



1. "**A**" is the center of the effective image area.
2. The two points "**B**" of the package are the horizontal reference.
   The point "**B**" of the package is the vertical reference.
3. The bottom "**C**" of the package, and the top of the cover glass "**D**" are the height reference.
4. The center of the effective image area relative to "**B**" and "**B**" is (H, V) = (8.0, 7.1) ± 0.075mm.
5. The rotation angle of the effective image area relative to H and V is ± 1°
6. The height from the bottom "**C**" to the effective image area is 1.41mm ± 0.1mm.
   The height from the top of the cover glass "**D**" to the effective image area is 1.49mm ± 0.15mm
7. The tilt of the effective image area relative to the bottom "**C**" is less than 35µm.
   The tilt of the effective image area relative to the top "**D**" of the cover glass is less than 50µm.
8. The thickness of the cover glass is 0.5mm, and the refractive index is 1.5.
9. The notch of the package is used only for directional index, that must not be used for reference of fixing.

PACKAGE STRUCTURE

PACKAGE MATERIAL	Plastic
LEAD TREATMENT	GOLD PLATING
LEAD MATERIAL	42 ALLOY
PACKAGE MASS	1.20g
DRAWING NUMBER	AS-A16(E)